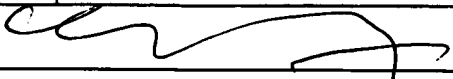


Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 105635.01		CONTINUATION APPLICATION OF APPLICATION NO. 09/519,463	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Eiichi TAKAHASHI et al.			
				FILING DATE September 24, 2003			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
EL		5,475,830	12/1995	Chen et al.			
EL		6,269,451	07/2001	Mullarkey	713	401	
EL		4,697,242	09/1987	Holland et al.	706	13	
EL		5,224,056	06/1993	Chene et al.	716	7	
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EL		4,796,259 A	01/1989	Troy	714	731	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
EL		JP-A-6-295319	10/1994	Japan			
EL		JP-A-10-21279 (w/Abstract and translation)	1/1998	Japan			
EL		JP-A-9-330350 (w/Abstract and translation)	12/1997	Japan			
EL		JP-A-7-134700 (w/Abstract and translation)	5/1995	Japan			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EL		AIST Press Release, "AIST Team Develops Genetic Algorithm-Based Method to Adjust Clock Timing that Allows Power					
		Consumption to be Halved in High-Speed LSIs: Adjusted Clock Timing Provides Enhanced Clock Frequencies and					
		Reduced Design Times", June 11, 2003 (in Japanese w/English Summary)					
EXAMINER					DATE CONSIDERED		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: September 29, 2003

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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
tl		09/397,636	09/1999	Tetsuya HIGUCHI et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
tl		JP-A-10-111861 (w/Abstract and translation)	4/1998	Japan			
sl		JP-A-3-117210 (w/Abstract)	5/1991	Japan			
sl		JP-A-6-3419 (w/Abstract with translation)	1/1994	Japan			
tl		JP-A-6-75018 (w/Abstract and translation)	3/1994	Japan			
sl		JP-A-4-23172 (w/Abstract)	1/1992	Japan			
sl		JP-A-9-325949 (w/Abstract and translation)	12/1997	Japan			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER					DATE CONSIDERED		
					7/14/03		
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